

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	1	detect\$3 same (surface with shape) same (contact with pad) same (contact with probe) same (three-dimensional with data)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 17:47
S2	1	(detect\$3 same (surface with shape) same (contact with pad)) and ((contact with probe) same (three-dimensional with data))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:32
S3	1	(detect\$3 same (surface with shape)) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:38
S4	31	(surface with shape) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:44
S5	28	((surface with shape) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)) and (circuit with substrate)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:47
S6	28	((surface with shape) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)) and (circuit with substrate)) and cross-section	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:40
S7	1	((surface with shape) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)) and (circuit with substrate)) and cross-section) and curvature	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:41
S8	1	((surface with shape) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)) and (circuit with substrate)) and cross-section) and (end near2 shape)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:42

S9	1	((surface with shape) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)) and ((surface with shape) same imag\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:44
S10	30	((surface with shape) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)) and imag\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:44
S11	1	((((surface with shape) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)) and imag\$3) and ((contact with probe) same (acceptable or defective)))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:45
S12	1	((contact with probe) same (acceptable or defective)) and (surface with shape) and (contact with pad) and (three-dimensional with data)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:46
S13	49	((contact with probe) same (acceptable or defective)) and (surface with shape) and (contact with pad)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 14:37
S14	1	(((((contact with probe) same (acceptable or defective)) and (surface with shape) and (contact with pad)) and (circuit with substrate)) and (analy\$4 with surface with shape) and imag\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:48
S15	1	(((((surface with shape) and (contact with pad) and (contact with probe) and (((three adj dimensional) or three-dimensional or 3D) with data)) and (circuit with substrate)) and cross-section) and (analy\$4 with surface with shape) and imag\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:48
S16	1	(((((contact with probe) same (acceptable or defective)) and (surface with shape) and (contact with pad)) and (circuit with substrate)) and ((surface with shape) same imag\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/15 18:49

S17	21	((contact with probe) same (acceptable or defective)) and (surface with shape) and (contact with pad)) and (circuit with substrate)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 11:34
S18	1	(probe with test\$3) and (predetermin\$6 with dimension) and (detect\$3 with impression)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 10:48
S19	8	"324"/\$.ccls. and (((contact with probe) same (acceptable or defective)) and (surface with shape) and (contact with pad)) and (circuit with substrate)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 11:17
S20	4	((contact with probe) same (acceptable or defective)) and (analy\$6 with surface) and (contact with pad)) and (circuit with substrate)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 12:16
S21	4	((contact with probe) same (acceptable or defective)) and (analy\$6 with surface) and (contact with pad)) and (imag\$3 same surface)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 14:30
S22	3	((contact with probe) same (acceptable or defective)) and (analy\$6 with surface) and (contact with pad)) and (probe with imag\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 14:31
S23	2	((contact with probe) same (acceptable or defective)) and (analy\$6 with surface) and (contact with pad)) and (probe with imag\$3)) and (tolerance with range)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 14:33
S24	2	((contact with probe) same (acceptable or defective)) and (analy\$6 with surface) and (contact with pad)) and (probe with imag\$3)) and (tolerance with range)) and (cross-section\$3 or (cross with section\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 14:34
S25	2	("702"/\$.ccls. or "342"/\$.ccls. or "356"/\$.ccls. or "367"/\$.ccls.) and ((contact with probe) same (acceptable or defective)) and (surface with shape) and (contact with pad)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 14:52

S26	1	((("702"/\$.ccls. or "342"/\$.ccls. or "356"/\$.ccls. or "367"/\$.ccls.) and ((contact with probe) same (acceptable or defective)) and (surface with shape) and (contact with pad)) and (imag\$3 with probe)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/09/16 14:52
S30	0	(deetect\$3 with surface with shape) and (analy\$3 with surface with shape)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 17:24
S31	293	(detect\$3 with surface with shape) and (analy\$3 with surface with shape)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 17:47
S32	50	S31 and (acceptable or defective)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 17:26
S33	3	S32 and (pressure with contact)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 17:27
S34	1	S33 and (integrat\$3 with circuit)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 17:28
S35	1	(detect\$3 with surface with shape) and (analy\$3 with surface with shape) and (circuit with chip) and (pressure with contact)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 17:50
S36	2	(detect\$3 with surface with shape) and (analy\$6 with surface with shape) and (circuit with chip) and (pressure with contact)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 17:50
S37	8	(detect\$3 with surface with shape) and (analy\$6 with surface with shape) and (imag\$3 with analy\$6) and (pressure with contact)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 17:54
S38	2	(detect\$3 with surface with shape) and (analy\$6 with surface with shape) and (contact with pad) and (contact with probe) and (surface with shape with imag\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 18:01

S39	1	(detect\$3 with surface with shape) and (contact with pad) and (contact with probe) and (surface with shape with imag\$3) and (three-dimensional or (three adj dimensional))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/08 18:08
S40	21	(detect\$3 with surface with shape) and (contact with probe) and (surface with shape with imag\$3) and (three-dimensional or (three adj dimensional))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/09 12:51
S41	27	("3585851" "3646805" "3918025" "3952150" "4597292" "4615217" "4747411" "4752896" "4768155" "4835688" "4843884" "4866614" "4880010" "4977512" "5078145" "5115401" "5121333" "5127037" "5128870" "5153721" "5184306" "5198990" "5243265" "5255681" "5257204" "5327351" "5343402").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/02/09 12:41
S42	13	S41 and (cross-section (cross adj section))	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/09 12:43
S43	0	S42 and (tolerance with range)	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/09 12:45
S44	0	S42 and ((cross-section or (cross adj section)) with range)	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/09 12:51
S45	0	S42 and ((cross-section (cross adj section)) with tolerance)	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/09 12:51
S46	0	S42 and ((cross-section (cross adj section)) same tolerance)	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/09 12:51
S47	0	S42 and ((cross-section or (cross adj section)) same range)	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/09 12:51
S48	1	(detect\$3 with surface with shape) and (contact with probe) and (surface with shape with imag\$3) and (three-dimensional or (three adj dimensional)) and (tolerance with range) and (cross-section (cross adj section))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/09 13:08

S49	1	(detect\$3 with surface with shape) and (surface with shape with imag\$3) and (three-dimensional or (three adj dimensional)) and (tolerance with range) and (cross-section (cross adj section))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/09 13:08
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